X- Beam Test

M. Montecchi ENEA-INFN Roma

CERN meeting January 16 2001

January 16, 2001

Requirements for the use in CMS





- **3)** Good mechanical adhesion with PWO, APD and capsule.
- 4) Chemical compatibility with APD
- 5) No degradation of light collection and mechanical adhesion along 10 years of CMS running:
 - radiation hard
 - negligible ageing
 - no disjunction or air bubbles formation

Considered glues for CMS (January 01)

product	<i>n</i> @ 430 nm ± 0.01	<a> (cm)	D/E (0.3 mm) (%)	D/E (1 mm) (%)	D/E (0.3 mm) epoxy window (%)
Histomount	1.63	> 10	12.0	12.0	11.2
3145	1.49	1.44 ± 0.06	9.4	9.1	9.4
NOA 61	1.59	0.55 ± 0.01	11.3	10.9	10.9
UVOH4	1.60	0.371 ± 0.009	11.0	10.4	10.7
Melmount 1.582	1.60	6.8 ± 1.5	11.4	11.4	11.1
Melmount 1.704	1.73	0.10 ± 0.01	12.8	11.6	10.3
Naphrax	1.80	0.086 ± 0.003	13.8	11.1	9.7
TSE 5250	1.47	> 30	9.4	9.4	9.4
615	1.47	> 15	9.4	9.4	9.4
301	1.57	2.8 ± 0.3	10.9	10.7	10.9
301-2	1.60	> 10	11.5	11.5	11.1
302	1.62	0.466 ± 0.009	11.5	10.6	10.8
X-38-4 06	1.53	> 25	10.3	10.3	10.3
Epoxy	1.57	12 ± 6	10.9	10.9	10.9



not rad hard

January 16, 2001



$$\frac{D}{E} = \frac{1}{2} \frac{\int_{0}^{\pi/2} d\theta \int_{330}^{615} d\lambda \ \frac{1}{2} \Big[T_p(\lambda,\theta) + T_s(\lambda,\theta) \Big] \ \text{IQE}(\lambda) S(\lambda)}{\int_{330}^{615} d\lambda \ S(\lambda)}$$

where

 λ wavelength, θ incidence angle

IQE(λ) internal quantum efficience of the APD

 $S(\lambda)$ PWO scintillation spectrum

 $T_p(\lambda,\theta), T_s(\lambda,\theta)$ p and s-polarised transmittance PWO \rightarrow Si

calculated with the optical constants of the crossed materials

Coupling medium	<i>n</i> @ 430 nm	<a> (cm)	D/E (%)	η
air	1	>> 10	3.50	1
Histomount	1.63	>10	11.19	3.2
DC3145	1.49	1.44 ± 0.06	9.39	2.7

January 16, 2001

X-Beam Test





January 16, 2001

X ray source at ENEA-Casaccia (National Institute of Metrology of Ionising Radiations)



C = collimatorF = FilterT = thermocoupleS = shutterX = X ray tube (CHF 320G Gilardoni)

- absolute measurement of dose and dose-rate
- energy spectrum
- beam qualification
- precise alignment of the sample (optical)

precise reproduction of the irradiation conditionsdose-rate < 1%</td>sample position <0.1mm</td>

January 16, 2001

Operational conditions

APD voltage supply

30 V to avoid gain fluctuations (M~1)

Readings:

- current by picoammeter (Kithley 485)
- output voltage by DAQ (NI 16XE50) and PC

 $\sigma \sim 0.02$ nA

Signal ~ nA with:

- X-tube alimentation: 250 kV, 10 mA
- filter P8, Be(3mm) +Al(4.06mm) +Cu(0.51mm)
- at 1m from the source ($\emptyset = 10 \text{ cm}$)

 $\langle E \rangle \sim 100 \text{ keV}$ dose-rate (air) ~ 1.5 10⁻³ Gy/s

January 16, 2001

Damage & Systematic



the exposure occurred during the very preliminary tests (filter, HV and *i*) is missing!!!

January 16, 2001

Damage & Systematic

• X-pulse of 20 sec: allows good signal precision, but causes damage

• damage ~10⁻² << η ~ 3 \Rightarrow does not wash out the gluing improvement but should be taken into account

1) fit with the function

$$y = P1 + P2 \exp\{-x/P3\} - P4x$$

$$\eta = \frac{y_{\text{GLUE}}(x_{\text{START}})}{y_{\text{AIR}}(x_{\text{END}})}$$

the signal reproducibility is better than
 0.4% for both X-source-switching and capsule-repositioning

Results

#	PWO	Capsule	glue	y_{END} (nA) @ 22 C	y _{START} (nA) @ 22 C	η
R	4025	110 old	/	1.975	2.025	1.025
Α	4091	165	Histo	1.648	4.015	2.436
B	4113	100	Histo	1.643	4.050	2.465
С	4114	70	DC3145	1.476	3.040	2.060
D	4115	85	DC3145	1.827	3.758	2.057

- slight recovery (+2.5%) of the reference crystal
- A \leftrightarrow B, C \leftrightarrow D good agreement !!!
- $\eta_{\text{EXP}} < \eta_{\text{CAL}}$: because of the depolished surface, but $\frac{\eta_{Histomount}}{\eta_{DC3145}} = 1.190 \pm 0.008$
- No bubbles observed with new capsules (flat APDs) during and after gluing procedure

January 16, 2001